

MC9S08PL16

MC9S08PL16 Series Data Sheet

Supports: MC9S08PL16 and
MC9S08PL8

Key features

- 8-Bit S08 central processor unit (CPU)
 - Up to 20 MHz bus at 2.7 V to 5.5 V across temperature range of -40 °C to 85 °C
 - Supporting up to 40 interrupt/reset sources
 - Supporting up to four-level nested interrupt
 - On-chip memory
 - Up to 16 KB flash read/program/erase over full operating voltage and temperature
 - Up to 256 byte EEPROM; 2-byte erase sector; program and erase while executing flash
 - Up to 2048 byte random-access memory (RAM)
 - Flash and RAM access protection
- Power-saving modes
 - One low-power stop mode; reduced power wait mode
 - Peripheral clock enable register can disable clocks to unused modules, reducing currents; allows clocks to remain enabled to specific peripherals in stop3 mode
- Clocks
 - Oscillator (XOSC) - loop-controlled Pierce oscillator; crystal or ceramic resonator range of 31.25 kHz to 39.0625 kHz or 4 MHz to 20 MHz
 - Internal clock source (ICS) - containing a frequency-locked-loop (FLL) controlled by internal or external reference; precision trimming of internal reference allowing 1% deviation across temperature range of 0 °C to 70 °C and 2% deviation across temperature range of -40 °C to 85 °C; up to 20 MHz
- System protection
 - Watchdog with independent clock source
 - Low-voltage detection with reset or interrupt; selectable trip points
 - Illegal opcode detection with reset
 - Illegal address detection with reset

- Development support
 - Single-wire background debug interface
 - Breakpoint capability to allow three breakpoints setting during in-circuit debugging
 - On-chip in-circuit emulator (ICE) debug module containing two comparators and nine trigger modes
- Peripherals
 - ADC - 12-channel, 10-bit resolution; 2.5 µs conversion time; data buffers with optional watermark; automatic compare function; internal bandgap reference channel; operation in stop mode; optional hardware trigger
 - CRC - programmable cyclic redundancy check module
 - FTM - two flex timer modulators modules including one 6-channel and one 2-channel ones; 16-bit counter; each channel can be configured for input capture, output compare, edge- or center-aligned PWM mode
 - MTIM - one modulo timers with 8-bit prescaler and overflow interrupt
 - RTC - 16-bit real timer counter (RTC)
 - SCI - two serial communication interface (SCI/UART) modules optional 13-bit break; full duplex non-return to zero (NRZ); LIN extension support
- Input/Output
 - Up to 30 GPIOs including one output-only pin
 - One 8-bit keyboard interrupt module (KBI)
 - Two true open-drain output pins
- Package options
 - 32-pin LQFP
 - 20-pin TSSOP
 - 16-pin TSSOP

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4.4 Voltage and current operating ratings

Absolute maximum ratings are stress ratings only, and functional operation at the maxima is not guaranteed. Stress beyond the limits specified in below table may affect device reliability or cause permanent damage to the device. For functional operating conditions, refer to the remaining tables in this document.

This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (for instance, either V_{SS} or V_{DD}) or the programmable pullup resistor associated with the pin is enabled.

Symbol	Description	Min.	Max.	Unit
V_{DD}	Supply voltage	-0.3	6.0	V
I_{DD}	Maximum current into V_{DD}	—	120	mA
V_{DIO}	Digital input voltage (except \bar{RESET} , EXTAL, XTAL, or true open drain pin)	-0.3	$V_{DD} + 0.3$	V
	Digital input voltage (true open drain pin)	-0.3	6	V
V_{AIO}	Analog ¹ , \bar{RESET} , EXTAL, and XTAL input voltage	-0.3	$V_{DD} + 0.3$	V
I_D	Instantaneous maximum current single pin limit (applies to all port pins)	-25	25	mA
V_{DDA}	Analog supply voltage	$V_{DD} - 0.3$	$V_{DD} + 0.3$	V

1. All digital I/O pins, except open-drain pin , are internally clamped to V_{SS} and V_{DD} . is only clamped to V_{SS} .

Nonswitching electrical specifications

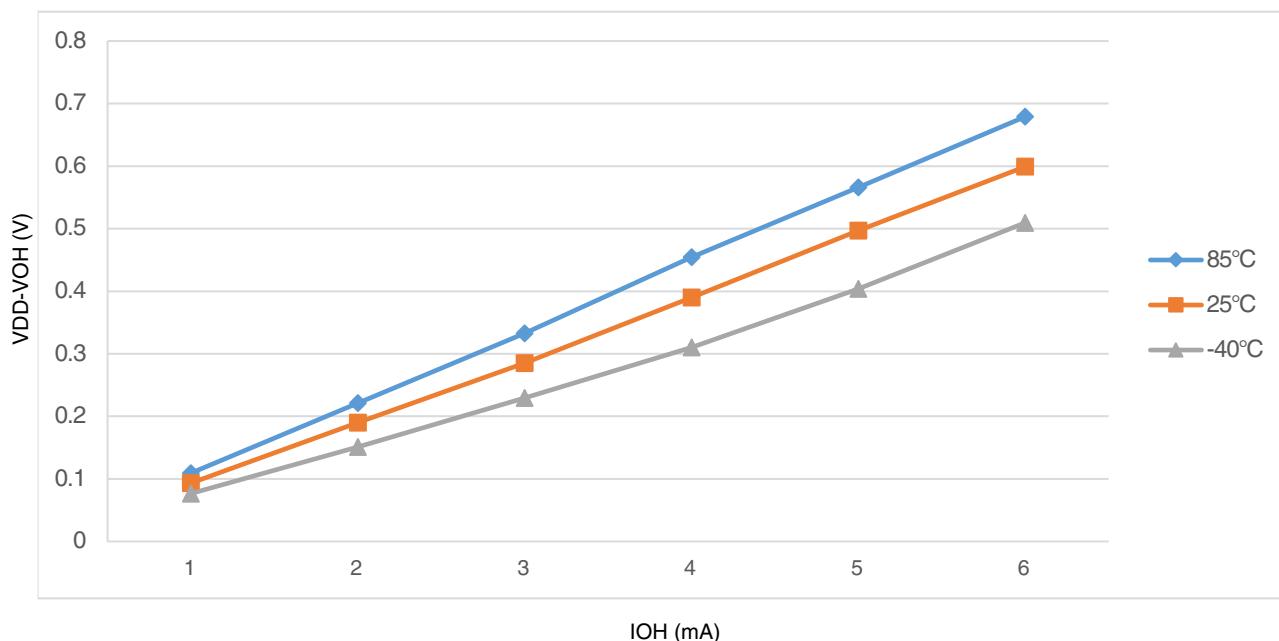


Figure 2. Typical I_{OH} Vs. $V_{DD}-V_{OH}$ (standard drive strength) ($V_{DD} = 3$ V)

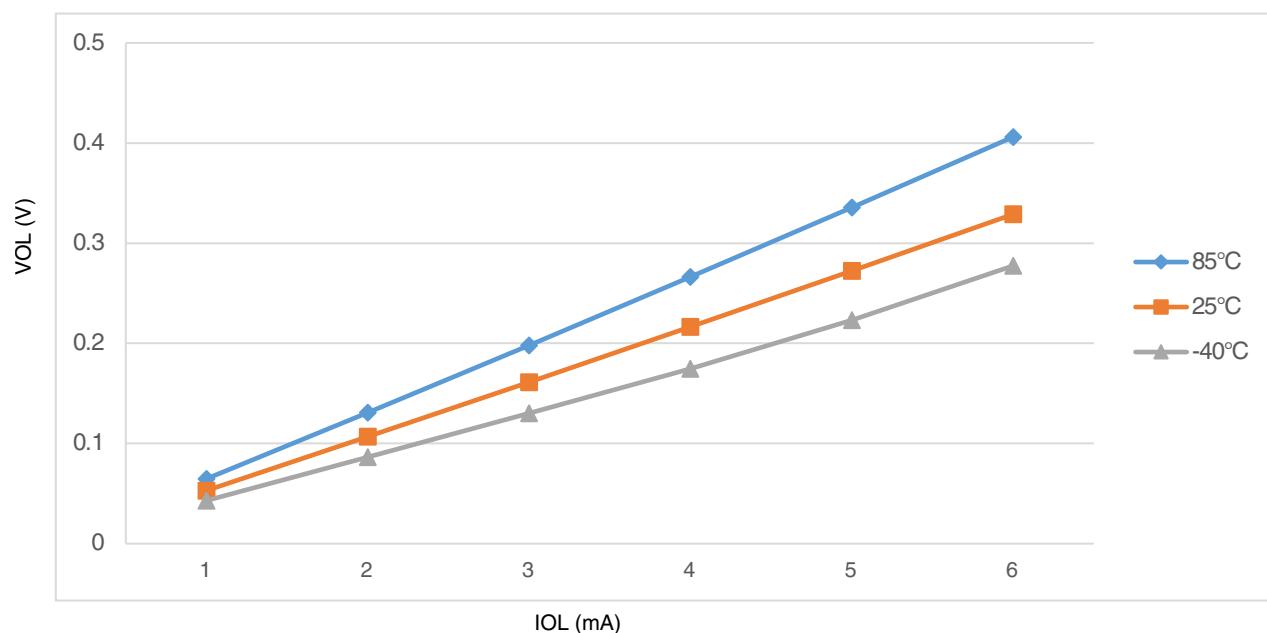


Figure 3. Typical I_{OL} Vs. V_{OL} (standard drive strength) ($V_{DD} = 5$ V)

Switching specifications

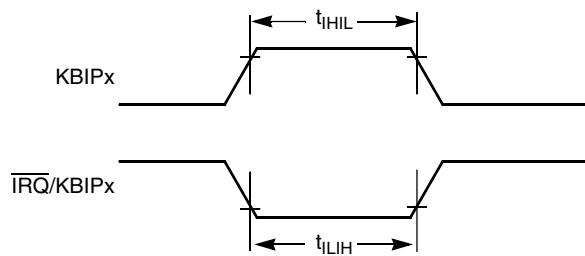


Figure 6. IRQ/KBIPx timing

5.2.2 Debug trace timing specifications

Table 7. Debug trace operating behaviors

Symbol	Description	Min.	Max.	Unit
t_{cyc}	Clock period		Frequency dependent	MHz
t_{wl}	Low pulse width	2	—	ns
t_{wh}	High pulse width	2	—	ns
t_r	Clock and data rise time	—	3	ns
t_f	Clock and data fall time	—	3	ns
t_s	Data setup	3	—	ns
t_h	Data hold	2	—	ns

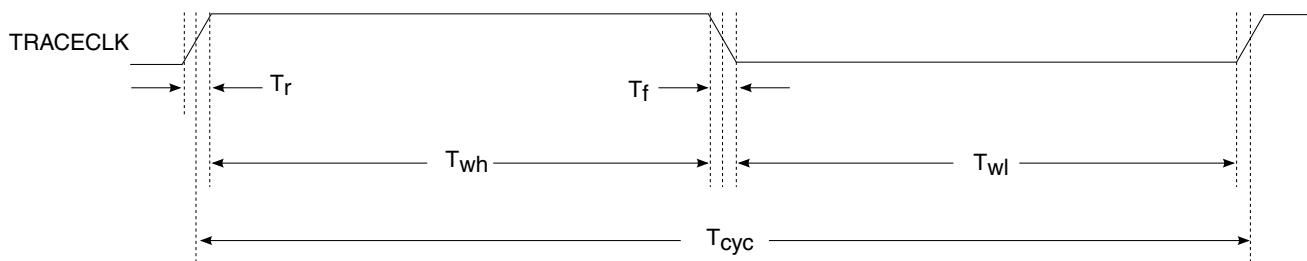


Figure 7. TRACE_CLKOUT specifications

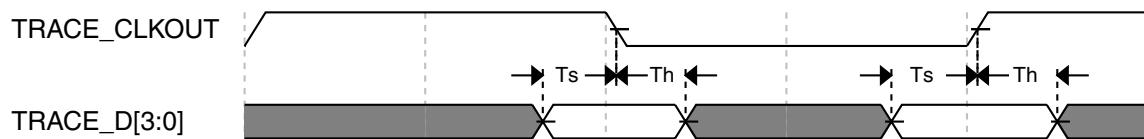


Figure 8. Trace data specifications

5.2.3 FTM module timing

Synchronizer circuits determine the shortest input pulses that can be recognized or the fastest clock that can be used as the optional external source to the timer counter. These synchronizers operate from the current bus rate clock.

Table 8. FTM input timing

No.	C	Function	Symbol	Min	Max	Unit
1	D	External clock frequency	f_{TCLK}	0	$f_{Bus}/4$	Hz
2	D	External clock period	t_{TCLK}	4	—	t_{cyc}
3	D	External clock high time	t_{clkh}	1.5	—	t_{cyc}
4	D	External clock low time	t_{clkI}	1.5	—	t_{cyc}
5	D	Input capture pulse width	t_{ICPW}	1.5	—	t_{cyc}

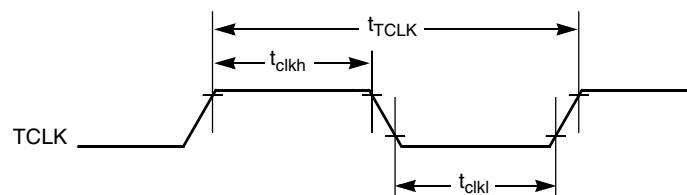


Figure 9. Timer external clock

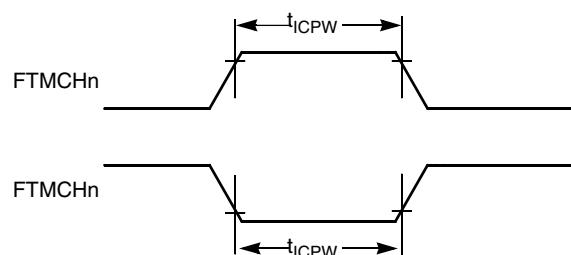


Figure 10. Timer input capture pulse

5.3 Thermal specifications

5.3.1 Thermal characteristics

This section provides information about operating temperature range, power dissipation, and package thermal resistance. Power dissipation on I/O pins is usually small compared to the power dissipation in on-chip logic and voltage regulator circuits, and it is user-determined rather than being controlled by the MCU design. To take $P_{I/O}$ into account in power calculations, determine the difference between actual pin voltage and V_{SS} or V_{DD} and multiply by the pin current for each I/O pin. Except in cases of unusually high pin current (heavy loads), the difference between pin voltage and V_{SS} or V_{DD} will be very small.

Table 9. Thermal characteristics

Rating	Symbol	Value	Unit
Operating temperature range (packaged)	T_A^1	T_L to T_H -40 to 85	°C
Junction temperature range	T_J	-40 to 105	°C
Thermal resistance single-layer board			
32-pin LQFP	$R_{\theta JA}$	88	°C/W
20-pin TSSOP	$R_{\theta JA}$	116	°C/W
16-pin TSSOP	$R_{\theta JA}$	130	°C/W
Thermal resistance four-layer board			
32-pin LQFP	$R_{\theta JA}$	59	°C/W
20-pin TSSOP	$R_{\theta JA}$	76	°C/W
16-pin TSSOP	$R_{\theta JA}$	87	°C/W

1. Maximum T_A can be exceeded only if the user ensures that T_J does not exceed the maximum. The simplest method to determine T_J is: $T_J = T_A + R_{\theta JA} \times \text{chip power dissipation}$.

6 Peripheral operating requirements and behaviors

6.1 External oscillator (XOSC) and ICS characteristics

Table 10. XOSC and ICS specifications (temperature range = -40 to 85 °C ambient)

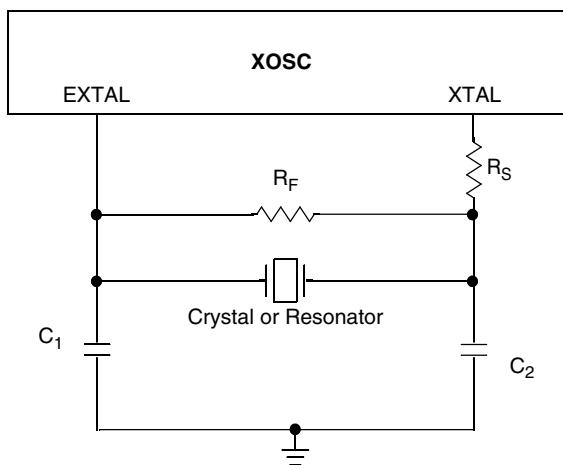
Num	C	Characteristic	Symbol	Min	Typical ¹	Max	Unit
1	C	Oscillator crystal or resonator	f_{lo}	31.25	32.768	39.0625	kHz
	C		f_{hi}	4	—	20	MHz
	C		f_{hi}	4	—	20	MHz
	C		f_{hi}	4	—	20	MHz
2	D	Load capacitors	C _{1, C₂}		See Note ³		
3	D	Feedback resistor	R_F	—	—	—	MΩ
				—	10	—	MΩ
				—	1	—	MΩ
				—	1	—	MΩ
4	D	Series resistor - Low Frequency	R_S	—	—	—	kΩ
				—	200	—	kΩ
5	D	Series resistor - High Frequency	R_S	—	—	—	kΩ
	D	4 MHz		—	0	—	kΩ
	D	8 MHz		—	0	—	kΩ
	D	16 MHz		—	0	—	kΩ
6	C	Crystal start-up time Low range = 32.768 kHz crystal; High range = 20 MHz crystal ^{5, 6}	t_{CSTL}	—	1000	—	ms
	C			—	800	—	ms
	C		t_{CSTH}	—	3	—	ms
	C			—	1.5	—	ms
7	T	Internal reference start-up time	t_{IRST}	—	20	50	μs
8	D	Square wave input clock frequency	f_{extal}	0.03125	—	5	MHz
	D			0	—	20	MHz
9	P	Average internal reference frequency - trimmed	f_{int_t}	—	—	—	kHz
10	P	DCO output frequency range - trimmed	f_{dco_t}	16	—	20	MHz
11	P	Total deviation of DCO output from trimmed frequency ⁵	Δf_{dco_t}	—	—	±2.0	% f_{dco}
	C	Over fixed voltage and temperature range of 0 to 70 °C		—	—	±1.0	
12	C	FLL acquisition time ^{5, 7}	$t_{Acquire}$	—	—	2	ms

Table continues on the next page...

**Table 10. XOSC and ICS specifications (temperature range = -40 to 85 °C ambient)
(continued)**

Num	C	Characteristic	Symbol	Min	Typical ¹	Max	Unit
13	C	Long term jitter of DCO output clock (averaged over 2 ms interval) ⁸	C_{jitter}	—	0.02	0.2	% f_{dco}

1. Data in Typical column was characterized at 5.0 V, 25 °C or is typical recommended value.
2. When ICS is configured for FEE or FBE mode, input clock source must be divisible using RDIV to within the range of 31.25 kHz to 39.0625 kHz.
3. See crystal or resonator manufacturer's recommendation.
4. Load capacitors (C_1, C_2), feedback resistor (R_F) and series resistor (R_S) are incorporated internally when RANGE = HGO = 0.
5. This parameter is characterized and not tested on each device.
6. Proper PC board layout procedures must be followed to achieve specifications.
7. This specification applies to any time the FLL reference source or reference divider is changed, trim value changed, or changing from FLL disabled (FBELP, FBILP) to FLL enabled (FEI, FEE, FBE, FBI). If a crystal/resonator is being used as the reference, this specification assumes it is already running.
8. Jitter is the average deviation from the programmed frequency measured over the specified interval at maximum f_{Bus} . Measurements are made with the device powered by filtered supplies and clocked by a stable external clock signal. Noise injected into the FLL circuitry via V_{DD} and V_{SS} and variation in crystal oscillator frequency increase the C_{jitter} percentage for a given interval.


Figure 11. Typical crystal or resonator circuit

6.2 NVM specifications

This section provides details about program/erase times and program/erase endurance for the flash and EEPROM memories.

Table 11. Flash characteristics

C	Characteristic	Symbol	Min ¹	Typical ²	Max ³	Unit ⁴
D	Supply voltage for program/erase -40 °C to 85 °C	$V_{\text{prog/erase}}$	2.7	—	5.5	V
D	Supply voltage for read operation	V_{Read}	2.7	—	5.5	V

Table continues on the next page...

Table 11. Flash characteristics (continued)

C	Characteristic	Symbol	Min ¹	Typical ²	Max ³	Unit ⁴
D	NVM Bus frequency	f _{NVMBUS}	1	—	25	MHz
D	NVM Operating frequency	f _{NVMOP}	0.8	1	1.05	MHz
D	Erase Verify All Blocks	t _{VFYALL}	—	—	17338	t _{cyc}
D	Erase Verify Flash Block	t _{RD1BLK}	—	—	16913	t _{cyc}
D	Erase Verify EEPROM Block	t _{RD1BLK}	—	—	810	t _{cyc}
D	Erase Verify Flash Section	t _{RD1SEC}	—	—	484	t _{cyc}
D	Erase Verify EEPROM Section	t _{DRD1SEC}	—	—	555	t _{cyc}
D	Read Once	t _{RDONCE}	—	—	450	t _{cyc}
D	Program Flash (2 word)	t _{PGM2}	0.12	0.12	0.29	ms
D	Program Flash (4 word)	t _{PGM4}	0.20	0.21	0.46	ms
D	Program Once	t _{PGMONCE}	0.20	0.21	0.21	ms
D	Program EEPROM (1 Byte)	t _{DPGM1}	0.10	0.10	0.27	ms
D	Program EEPROM (2 Byte)	t _{DPGM2}	0.17	0.18	0.43	ms
D	Program EEPROM (3 Byte)	t _{DPGM3}	0.25	0.26	0.60	ms
D	Program EEPROM (4 Byte)	t _{DPGM4}	0.32	0.33	0.77	ms
D	Erase All Blocks	t _{ERSALL}	96.01	100.78	101.49	ms
D	Erase Flash Block	t _{ERSBLK}	95.98	100.75	101.44	ms
D	Erase Flash Sector	t _{ERSPG}	19.10	20.05	20.08	ms
D	Erase EEPROM Sector	t _{DERSPG}	4.81	5.05	20.57	ms
D	Unsecure Flash	t _{UNSECU}	96.01	100.78	101.48	ms
D	Verify Backdoor Access Key	t _{VFYKEY}	—	—	464	t _{cyc}
D	Set User Margin Level	t _{MLOADU}	—	—	407	t _{cyc}
C	FLASH Program/erase endurance T _L to T _H = -40 °C to 85 °C	n _{FLPE}	10 k	100 k	—	Cycles
C	EEPROM Program/erase endurance TL to TH = -40 °C to 85 °C	n _{FLPE}	50 k	500 k	—	Cycles
C	Data retention at an average junction temperature of T _{Javg} = 85°C after up to 10,000 program/erase cycles	t _{D_ret}	15	100	—	years

1. Minimum times are based on maximum f_{NVMOP} and maximum f_{NVMBUS}

2. Typical times are based on typical f_{NVMOP} and maximum f_{NVMBUS}

3. Maximum times are based on typical f_{NVMOP} and typical f_{NVMBUS} plus aging

4. t_{cyc} = 1 / f_{NVMBUS}

Program and erase operations do not require any special power sources other than the normal V_{DD} supply. For more detailed information about program/erase operations, see the Memory section.

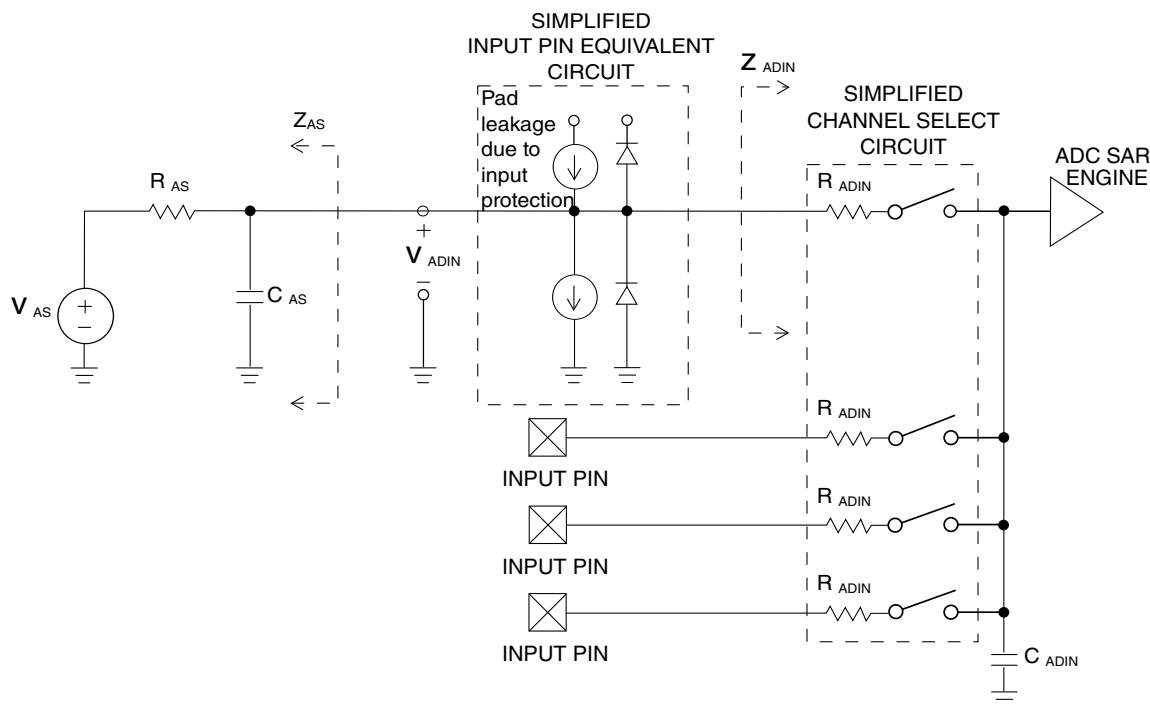


Figure 12. ADC input impedance equivalency diagram

Table 13. 10-bit ADC Characteristics ($V_{REFH} = V_{DDA}$, $V_{REFL} = V_{SSA}$)

Characteristic	Conditions	C	Symb	Min	Typ ¹	Max	Unit
Supply current ADLPC = 1 ADLSMP = 1 ADCO = 1		T	I _{DDA}	—	133	—	µA
Supply current ADLPC = 1 ADLSMP = 0 ADCO = 1		T	I _{DDA}	—	218	—	µA
Supply current ADLPC = 0 ADLSMP = 1 ADCO = 1		T	I _{DDA}	—	327	—	µA
Supply current ADLPC = 0 ADLSMP = 0 ADCO = 1		T	I _{DDAD}	—	582	990	µA
Supply current	Stop, reset, module off	T	I _{DDA}	—	0.011	1	µA
ADC asynchronous clock source	High speed (ADLPC = 0)	P	f _{ADACK}	2	3.3	5	MHz

Table continues on the next page...

To find a package drawing, go to nxp.com and perform a keyword search for the drawing's document number:

If you want the drawing for this package	Then use this document number
16-pin TSSOP	98ASH70247A
20-pin TSSOP	98ASH70169A
32-pin LQFP	98ASH70029A

8 Pinout

8.1 Signal multiplexing and pin assignments

The following table shows the signals available on each pin and the locations of these pins on the devices supported by this document. The Port Control Module is responsible for selecting which ALT functionality is available on each pin.

Table 14. Pin availability by package pin-count

Pin Number			Lowest Priority <--> Highest				
32-LQFP	20-TSSOP	16-TSSOP	Port Pin	Alt 1	Alt 2	Alt 3	Alt 4
1	—	—	PTD1	—	FTM2CH3	—	—
2	—	—	PTD0	—	FTM2CH2	—	—
3	—	—	PTE4	—	TCLK2	—	—
4	3	3	—	—	—	—	V _{DD}
5	4	4	—	—	—	—	V _{SS}
6	5	5	PTB7	—	—	—	EXTAL
7	6	6	PTB6	—	—	—	XTAL
8	7	7	PTB5	—	FTM2CH5	—	—
9	8	8	PTB4	—	FTM2CH4	—	—
10	9	—	PTC3	—	FTM2CH3	ADP11	—
11	10	—	PTC2	—	FTM2CH2	ADP10	—
12	—	—	PTD7	—	—	—	—
13	—	—	PTD6	—	—	—	—
14	11	—	PTC1	—	FTM2CH1	ADP9	—
15	12	—	PTC0	—	FTM2CH0	ADP8	—
16	13	9	PTB3	KBI0P7	—	ADP7	—
17	14	10	PTB2	KBI0P6	—	ADP6	—
18	15	11	PTB1	KBI0P5	TXD0	ADP5	—
19	16	12	PTB0	KBI0P4	RXD0	ADP4	—

Table continues on the next page...

Table 14. Pin availability by package pin-count (continued)

Pin Number			Lowest Priority <--> Highest				
32-LQFP	20-TSSOP	16-TSSOP	Port Pin	Alt 1	Alt 2	Alt 3	Alt 4
20	—	—	PTA7	—	—	ADP3	—
21	—	—	PTA6	—	—	ADP2	—
22	—	—	PTD2	—	—	—	—
23	17	13	PTA3 ¹	KBI0P3	TXD0	—	—
24	18	14	PTA2 ¹	KBI0P2	RXD0	—	—
25	19	15	PTA1	KBI0P1	FTM0CH1	—	ADP1
26	20	16	PTA0	KBI0P0	FTM0CH0	—	ADP0
27	—	—	PTC7	—	TxD1	—	—
28	—	—	PTC6	—	RxD1	—	—
29	—	—	PTC5	—	FTM0CH1	—	—
30	—	—	PTC4	—	FTM0CH0	—	—
31	1	1	PTA5	IRQ	TCLK0	—	RESET
32	2	2	PTA4	—	—	BKGD	MS

1. This is a true open-drain pin when operated as output.

Note

When an alternative function is first enabled, it is possible to get a spurious edge to the module. User software must clear any associated flags before interrupts are enabled. The table above illustrates the priority if multiple modules are enabled. The highest priority module will have control over the pin. Selecting a higher priority pin function with a lower priority function already enabled can cause spurious edges to the lower priority module. Disable all modules that share a pin before enabling another module.

8.2 Device pin assignment

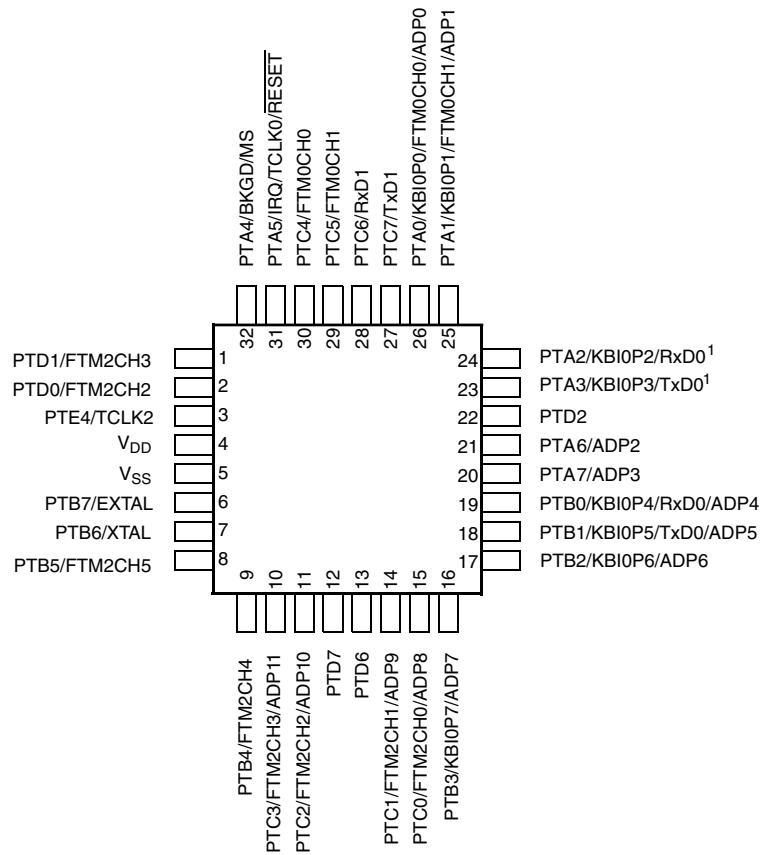


Figure 13. 32-pin LQFP package

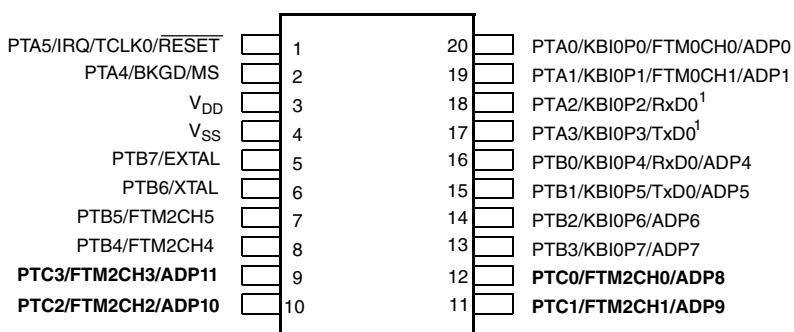
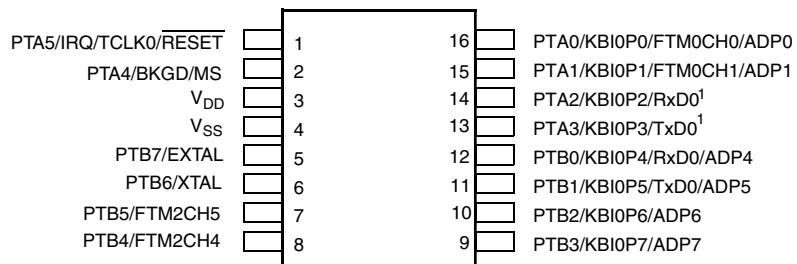


Figure 14. 20-pin TSSOP package

Revision history



Pins in **bold** are not available on less pin-count packages.
1. True open drain pins

Figure 15. 16-pin TSSOP package

9 Revision history

The following table provides a revision history for this document.

Table 15. Revision history

Rev. No.	Date	Substantial Changes
0	03/2018	Initial Created
0.1	03/2018	Updated ordering information.
1	04/2018	Completed all the TBDs and added 20-pin TSSOP and 16-pin TSSOP packages.

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